Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/751,469	LEE ET AL.	
Examiner	Art Unit	
Linh V. Nguyen	2819	

SEARCHED						
Class	Subclass	Date	Examiner			
330	255,252 253,261 264,265	2/6/2006	LN			
			;			
		į				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		. <u> </u>			

ES STRATEGY	)
DATE	EXMR
2/6/2006	LN
	DATE